Notice of References Cited

Application/Control No. 10/593,477	Applicant(s)/Patent Under Reexamination KOSHINO ET AL.		
Examiner	Art Unit		
Andrew C. Lee	2419	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0198780	12-2002	Kawakami et al.	705/14
*	В	US-6,222,536	04-2001	Kihl et al.	709/203
*	υ	US-2001/0046212	11-2001	Nakajima, Masaki	370/278
*	D	US-6,738,822	05-2004	Fukasawa et al.	709/231
*	Е	US-6,633,866	10-2003	Kishigami, Tohru	707/3
*	F	US-2002/0143663	10-2002	Walsh et al.	705/27
*	G	US-6,856,593	02-2005	Nakajima, Masaki	370/218
*	н	US-2001/0044819	11-2001	GONG, QING	709/202
*	-	US-7,130,307	10-2006	Nakamura et al.	370/395.5
*	7	US-2004/0215568	10-2004	Fukushima et al.	705/051
*	К	US-2004/0044775	03-2004	Takano et al.	709/227
*	L	US-7,269,662	09-2007	Takeuchi et al.	709/232
*	М	US-2003/0193967	10-2003	Fenton et al.	370/490

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	x			

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